## Notice of References Cited Application/Control No. 10/597,614 Examiner NIGAR CHOWDHURY Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,206,892	04-2007	Kim et al.	711/100
*	В	US-6,360,053	03-2002	Wood et al.	386/67
*	С	US-4,873,584	10-1989	Hashimoto, Kazuo	386/83
*	D	US-7,672,566	03-2010	Seo et al.	386/55
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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